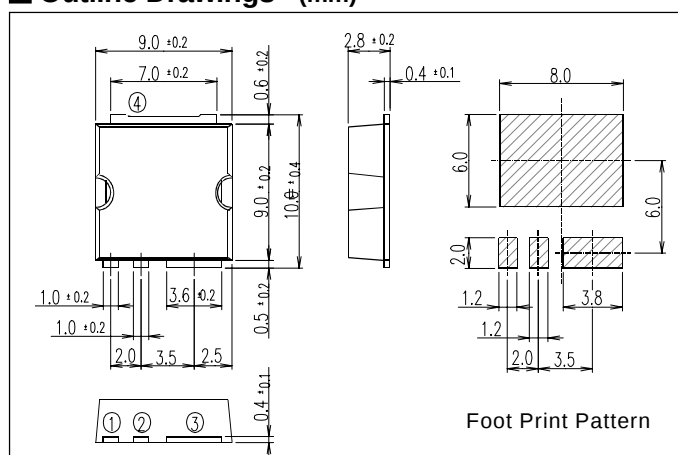


FUJI POWER MOSFET

Super FAP-G Series

N-CHANNEL SILICON POWER MOSFET

■ Outline Drawings (mm)



■ Features

High speed switching
Low on-resistance
No secondary breakdown
Low driving power
Avalanche-proof

■ Applications

Switching regulators
UPS (Uninterruptible Power Supply)
DC-DC converters

■ Maximum ratings and characteristic

Absolute maximum ratings

● (T_c=25°C unless otherwise specified)

(Tc=25 °C unless otherwise specified)				
Item	Symbol	Ratings	Unit	
Drain-source voltage	V _{DS}	100	V	
	V _{DSX} *5	70	V	
Continuous drain current	I _D	Tc=25°C	±29	A
		Ta=25°C	±4.4 **	A
Pulsed drain current	I _{D(puls)}	±116	A	
Gate-source voltage	V _{GS}	±30	V	
Non-repetitive Avalanche current	I _{AS} *2	29	A	
Maximum Avalanche Energy	E _{AS} *1	155.8	mJ	
Maximum Drain-Source dV/dt	dV _{DS} /dt *4	20	kV/μs	
Peak Diode Recovery dV/dt	dV/dt *3	5	kV/μs	
Max. power dissipation	P _D	Tc=25°C	105	W
		Ta=25°C	2.4 **	
Operating and storage temperature range	T _{ch}	+150	°C	
	T _{stg}	-55 to +150	°C	

** Surface mounted on 1000mm², t=1.6mm FR-4 PCB(Drain pad area : 500mm²)

*1 L=222μH, V_{CC}=48V, T_{ch}=25°C, See to Avalanche Energy Graph *2 T_{ch} ≤150°C

*3 I_F ≤ -I_D, -di/dt=50A/μs, V_{CC} ≤ BV_{DSS}, T_{ch} ≤ 150°C *4 V_{DS} ≤ 100V *5 V_{GS}=-30V

● Electrical characteristics (T_c =25°C unless otherwise specified)

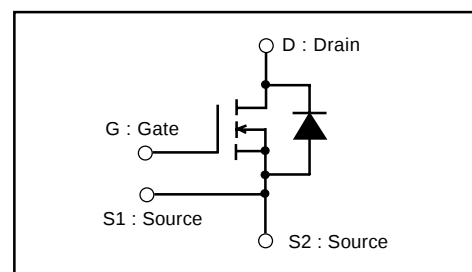
Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-source breakdown voltage	V _{(BR)DSS}	I _D = 250μA V _{GS} =0V	100			V
Gate threshold voltage	V _{GS(th)}	I _D = 250μA V _{DS} =V _{GS}	3.0		5.0	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =100V V _{GS} =0V			25	μA
		V _{DS} =80V V _{GS} =0V			250	μA
Gate-source leakage current	I _{GSS}	V _{GS} =±30V V _{DS} =0V		10	100	nA
Drain-source on-state resistance	R _{DS(on)}	I _D =10A V _{GS} =10V		47	62	mΩ
Forward transconductance	g _{fs}	I _D =10A V _{DS} =25V	6	12		S
Input capacitance	C _{iss}	V _{DS} =75V		730	1095	pF
Output capacitance	C _{oss}	V _{GS} =0V		190	285	pF
Reverse transfer capacitance	C _{rss}	f=1MHz		12	18	pF
Turn-on time t _{on}	td(on)	V _{CC} =48V I _D =10A		12	18	ns
	t _r	V _{GS} =10V		3.8	6	ns
Turn-off time t _{off}	td(off)	R _{GS} =10 Ω		23	35	ns
	t _f			8.5	13	ns
Total Gate Charge	Q _G	V _{CC} =50V		22	33	nC
Gate-Source Charge	Q _{GS}	I _D =20A		9	13.5	nC
Gate-Drain Charge	Q _{GD}	V _{GS} =10V		6	9	nC
Avalanche capability	I _{AV}	L=222μH T _{ch} =25°C	29			A
Diode forward on-voltage	V _{SD}	I _F =20A V _{GS} =0V T _{ch} =25°C		1.10	1.65	V
Reverse recovery time	t _{rr}	I _F =20A V _{GS} =0V		65		ns
Reverse recovery charge	Q _{rr}	-di/dt=100A/μs T _{ch} =25°C		0.17		μC

● Thermal characteristics

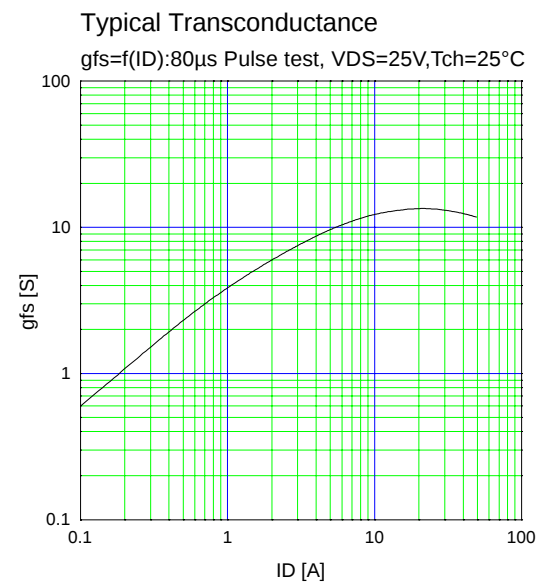
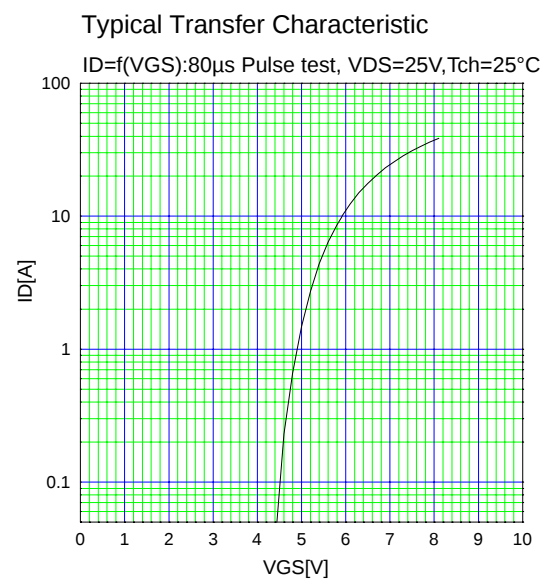
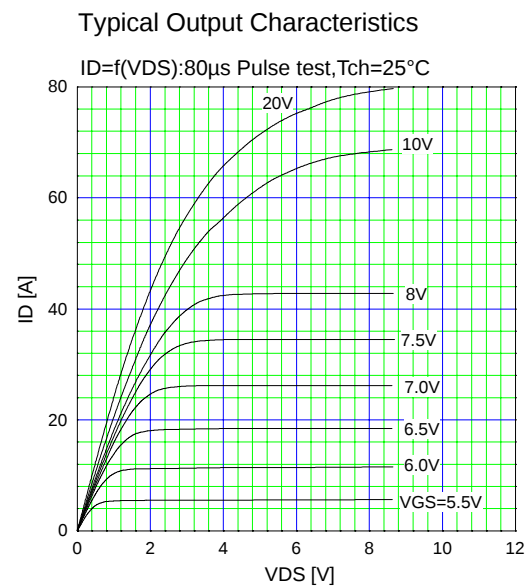
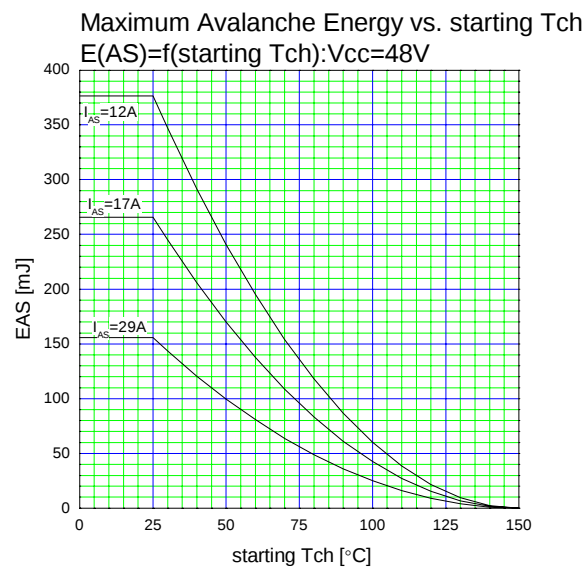
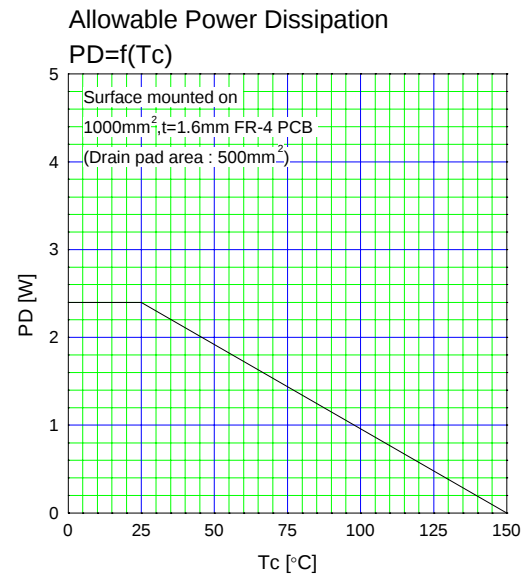
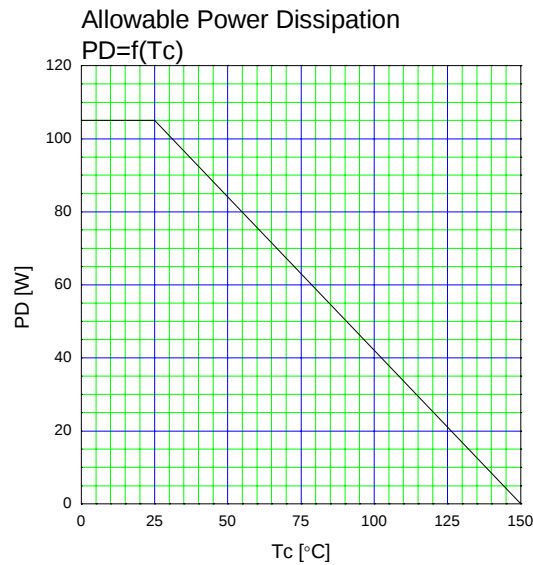
Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	R _{th(ch-c)}	channel to case			1.191	°C/W
	R _{th(ch-a)}	channel to ambient			87.0	°C/W
	R _{th(ch-a)} **	channel to ambient			52.0	°C/W

** Surface mounted on 1000mm², t=1.6mm FR-4 PCB(Drain pad area : 500mm²)

■ Equivalent circuit schematic

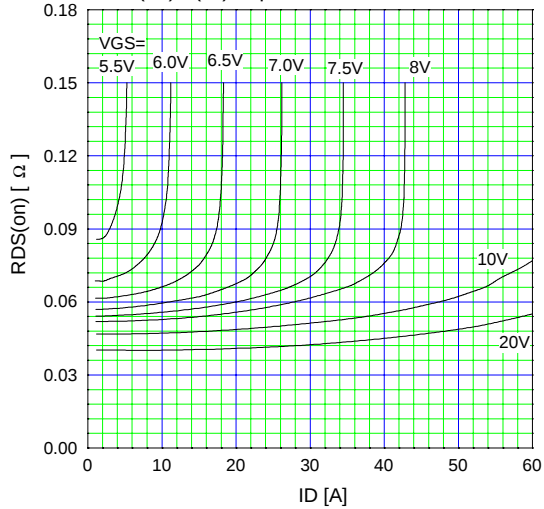


Characteristics



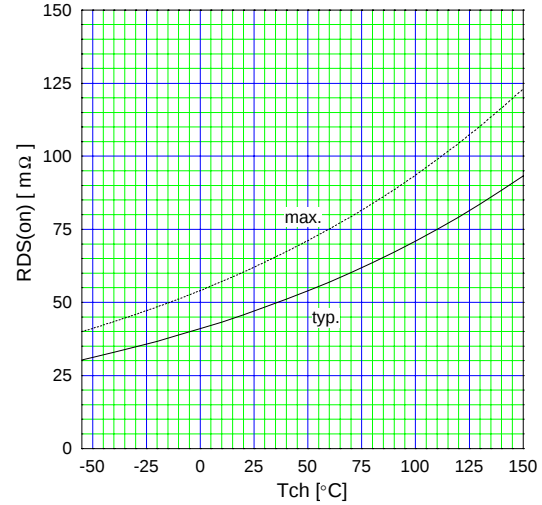
Typical Drain-Source on-state Resistance

$R_{DS(on)} = f(I_D)$: 80 μ s Pulse test, $T_{ch} = 25^\circ\text{C}$



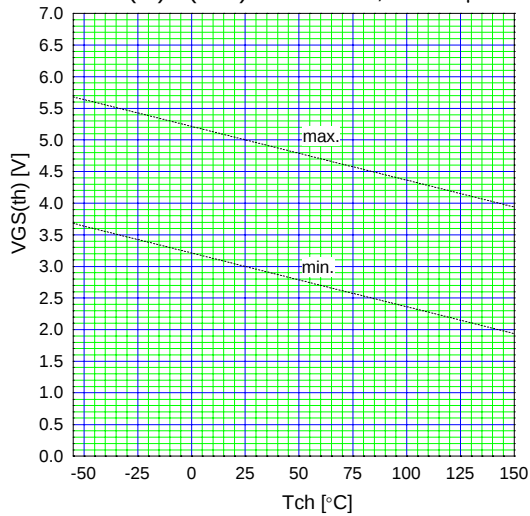
Drain-Source On-state Resistance

$R_{DS(on)} = f(T_{ch})$: $I_D = 10\text{A}$, $V_{GS} = 10\text{V}$



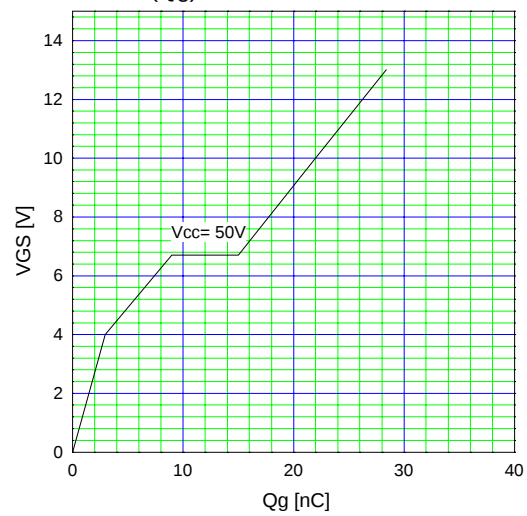
Gate Threshold Voltage vs. T_{ch}

$V_{GS(th)} = f(T_{ch})$: $V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$



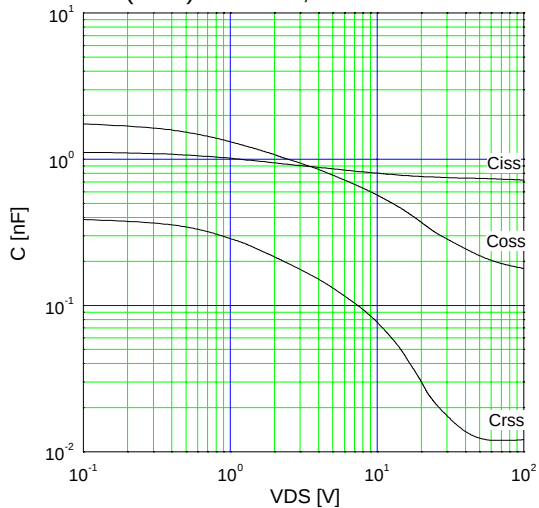
Typical Gate Charge Characteristics

$V_{GS} = f(Q_g)$: $I_D = 20\text{A}$, $T_{ch} = 25^\circ\text{C}$



Typical Capacitance

$C = f(V_{DS})$: $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$



Typical Forward Characteristics of Reverse Diode

$I_F = f(V_{SD})$: 80 μ s Pulse test, $T_{ch} = 25^\circ\text{C}$

